

PHOTON RT

UV-VIS-MWIR SPECTROPHOTOMETERS FOR COATERS



ADVANCED SOLUTIONS FOR TESTING OF OPTICAL COATINGS

PHOTON RT

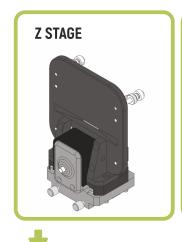
THE ONLY INSTRUMENT DESIGNED SPECIFICALLY TO TEST OPTICAL COATINGS

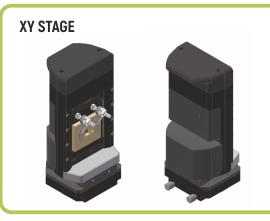


UNIQUE DESIGN

- Unique optical design measurement from 185 nm up to 5200 nm in one instrument
- Multi-axis movement of the measurement channel testing of sophisticated cemented prisms at any angles of incidence with variable off-set or arbitrary direction of the outgoing beam
- Special low-noise detectors are selected to qualify coatings with extreme specifications
- Optional sample stages designed for fast, complex or batch measurements
- Improved monochromator generates a highly collimated beam, produces low stray light and gives a high signal-to-noise ratio

AUTO-DETECT MOTORIZED STAGES







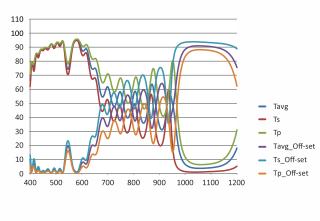
Offers baseline calibration and subsequent test without user intervention

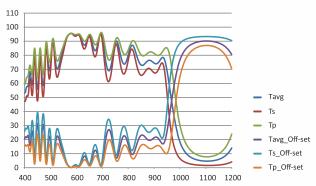
Designed for testing a sample at multiple surface points

Designed for fully automatic testing of 7 samples (1" or 30 mm OD size) including baseline calibration

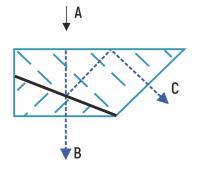
UNIQUE RESULTS*

MEASUREMENT OF COMPLEX PRISMS WITH BEAM OFFSET



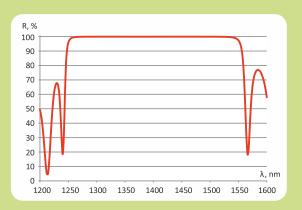


CEMENTED PRISM WITH BEAM OFF-SET



Measurement of beams B and C in one run without moving the sample *The example results shown are ONLY obtainable by using the PHOTON RT

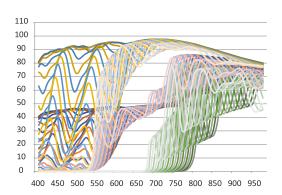
◆ 1392 nm BroadbandNEAR IR LASER MIRROR

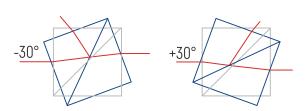


Max measured absolute specular reflectance:

99,9953%

BEAM SPLITTER MEASUREMENTSAT VARIABLE AOI





Designed specifically for optics used in AR and VR devices

SPECIFICATIONS

			RT Spectrophotometer				
PRODUCT SPECIFICATIONS	185 - 1700	185 - 3500	185 - 5200	380 - 1700	380 - 3500	380 - 5200	
Optical scheme of monochromator	Czerny-Turner						
Optics	Mirror, MgF2						
Reference channel	Yes						
Wavelength sampling pitch, nm	0,1-100						
Wavelength scanning speed, nm/min	3 000 (at 5 nm wa	3 000 (at 5 nm wavelength sampling pitch)					
Spot size on the measured sample, mm	6 x 2						
Turning pitch angle of sample stage	0,01 deg						
	0,01 deg						
Turning pitch angle of photodetectors	-	(t l d	u u-aatat1				
Beam displacement compensation Variable angle measurements	-60 mm 0 +60 mm (actual value depends on detector position) 1. 0-75 deg for transmittance (up to 85 deg with 70-85 sample stage) 2. 8-75 deg for absolute reflectance (up to 85 deg with 70-85 sample stage) 3. Detector rotation range: 300 deg 180 deg 16 deg 4. Sample stage rotation range: -85 deg 0 deg +85 deg						
Wavelength subranges, nm	Ultimate spectral (non-polarized ligh		Wavelength accurac	Wavelength accuracy, nm		Wavelength repeat accuracy, nm	
185 - 350 nm	0,3		+/- 0,25		+/- 0,12		
350 (380) - 990 nm	0,6		+/- 0,5		+/- 0,25		
990 - 1700 nm	1,2	+/- 1,0			+/- 0,5		
1700 - 2450 nm	1,2		+/- 1,0		+/- 0,5		
2450 - 5200 nm	2,4			+/- 1,0			
	2,4 +/- 2,0 +/- 1,0 < 0.1						
Stray light level, % at 532 nm							
Angle of beam divergence	+/-1 deg						
Photometric accuracy	(VIS) NIST SRM 930e: +/-0.003 Abs (1 Abs) NIST SRM 1930: +/-0.003 Abs (0.33 Abs); +/-0.006 Abs (2 Abs) (MWIR) NRC NG11 SRM: +/-0.0013 Abs (0.13 Abs); +/-0.0053 Abs (0.49 Abs); +/-0.0011 Abs (0.82 Abs); +/-0.005 Abs (1.0 Abs)						
Photometric repeat accuracy (VIS range)	(VIS) NIST SRM 930e: 0.0004 Abs (1 Abs) NIST SRM 1930: 0.0001 Abs (0.33 Abs); 0.005 Abs (2 Abs) (MWIR) NRC NG11 SRM: +/-0.0003 Abs (0.13 Abs); +/-0.0008 Abs (0.49 Abs); +/-0.0022 Abs (0.82 Abs); +/-0.0034 Abs (1.0 Abs) Determined using 0,1 second accumulation, maximum deviation for 10 subsequent measurements						
Stability of baseline, %/hour (VIS range)	< 0,1 (One hour warm-up time)						
Unattended polarization measurements	a. S. P. (S+P)/2, Random						
with built-in polarizers		:P ratio for incident beam	(20/80_30/70_etc)				
Built-in polarizers, nm	220 - 1700	220 - 3500	220 - 5200	380 - 1700	380 - 3500	380 - 5200	
Zero order / Green beam			220 - 3200	300 - 1700	300 - 3300	300 - 3200	
Zero order / Green beam	Built-in, automation						
Light sources, preinstalled		Halogen lamp: 1 ea HgAr wavelength calibratio 1 ea Deuterium lamp: 1	ea Deuterium lamp: 1	ea ea		ID	
		6	IR source: 1 ea			IR source: 1 e	
Light sources, spare	Halogen lamp: 2 e	a (included into shipment)	l. Other light sources can	be ordered as spare	s as well.		
SAMPLE COMPARTMENT							
Dovetail baseplate for sample stages	Designed for mou	ınting of motorized and no	n-motorized sample stag	es. Integrated contro	oller ensures instant detec	tion of the motorized	
Planar sample stage	For measurement of transmission and reflection of planar samples with size bigger than 12x10 mm.						
Independent positioning	Independent computer controlled positioning of sample stage and photodetectors unit						
Synchronized positioning	Synchronized computer controlled positioning for sample stage and photodetectors unit depending on the chosen photometric function						
Synchronized positioning	Synchiconized COM	ipater controlled positionii	ng ror sample stage and	priotouetectors unit	neherraring our rue cuoseu	photometric runction	
Size of samples	Min. 12 x 10 mm – for measurement at 0 - 10 deg incidence angles. Min. 12 x 25 mm - for measurement at 10 - 75 deg incidence angles Max. sample size: - up to 152,4 mm (6°) with closed lid for standard sample stage - up to 140,0 mm (5 1/2°) with closed lid for Z sample stage						
Sample stage for PBS cubes	50 x 50 x 50 mm s	ample stage with two add	litional cube holders 1" x 1'	x 1" and 1/2" x 1/2" x	1/2"		
Optional motorized and non-motorized sample stages	1. Multiposition Stage base, motorized, auto-detect 11. 1" / 8 position disk for multiposition stage base 12. 30 mm / 8 position disk for multiposition stage base 2. XY Stage. +/- 12,5 mm travel. Sample size 40x44 mm 3. Z Stage 4. 70-85 deg AOI Sample Stage, not motorized (Photon RT 1) 5. 70-85 deg AOI Sample Stage, not motorized (Photon RT 2)						
INTERFACE, DIMENSIONS AND WEIGHT							
THE EXTROC, DIFFERENCES AND WEIGHT	USR 2.0 Windows, based English						
Interface	USB 2.0, Windows-based, English						
Interface File soving formate	res (txt), xls, pdf, csv						
File saving formats		SSV					
File saving formats Power consumption, Watt	110						
File saving formats Power consumption, Watt Power input	110 110-220 V (+/- 10%	(), 50-60 Hz					
File saving formats Power consumption, Watt Power input Purging	110 110-220 V (+/- 10% Sample compartn	i), 50-60 Hz nent, light sources, monoc					
File saving formats Power consumption, Watt	110 110-220 V (+/- 10% Sample compartn	(), 50-60 Hz		feet			
File saving formats Power consumption, Watt Power input Purging	110 110-220 V (+/- 10% Sample compartn	i), 50-60 Hz nent, light sources, monoc		feet			





